

# SN75ALS1177, SN75ALS1178 Dual Differential Drivers and Receivers

## 1 Features

- Meet or exceed standards TIA/EIA-422-B and TIA/EIA-485-A
- Designed for multipoint bus transmission on long bus lines in noisy environments
- Low supply-current requirement 50mA maximum
- Driver positive-and negative-current limiting
- Driver common-mode output voltage range of –7V to 12V
- Thermal shutdown protection driver 3-state outputs active-high enable
- Receiver common-mode input voltage range of –12V to 12V
- Receiver input sensitivity:  $\pm 200\text{mV}$
- Receiver hysteresis: 50mV typical
- Receiver high input impedance: 12k $\Omega$  minimum
- Receiver 3-state outputs active-low enable for SN75ALS1177 only
- Operate from single 5V supply

## 2 Applications

- [Motor Drives](#)
- [Factory Automation](#)
- [Building Automation](#)

## 3 Description

The SN75ALS1177 and SN75ALS1178 dual differential drivers and receivers are integrated circuits designed for bidirectional data communication on multipoint bus transmission lines. The devices are designed for balanced transmission lines, and meet standards TIA/EIA-422-B and TIA/EIA-485-A.

The SN75ALS1177 combines dual 3-state differential line drivers and dual 3-state differential input line receivers, both of which operate from a single 5V power supply. The drivers and receivers have active-high and active-low enables, respectively, which can be externally connected together to function as direction control. The SN75ALS1178 drivers each have an individual active-high enable. Fail-safe design ensures that when the receiver inputs are open, the receiver outputs are always high.

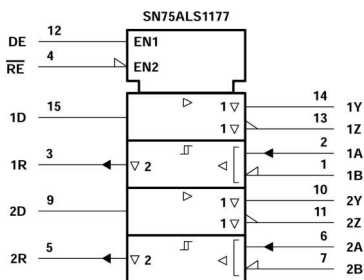
The SN75ALS1177 and SN75ALS1178 are characterized for operation from 0°C to 70°C.

### Package Options

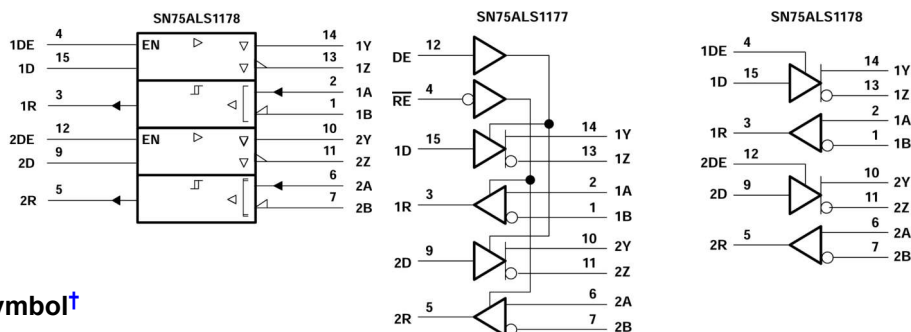
PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE <sup>(2)</sup>
SN75ALS1177	SOP (NS, 16)	10.2mm × 7.8mm
SN75ALS1178	PDIP (N, 16)	19.3mm × 9.4mm

(1) For more information, see [Section 10](#).

(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Logic Symbol†



Logic Diagram (Positive Logic)

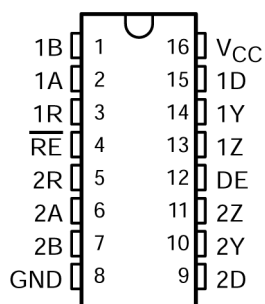
† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



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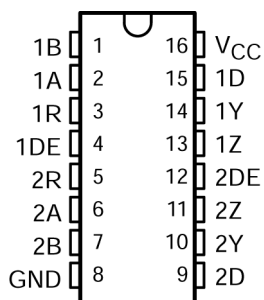
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## 4 Pin Configuration and Functions



**Figure 4-1. SN75ALS1177: N or NS Package  
(Top View)**

PIN			TYPE	DESCRIPTION
NAME	SO	TSSOP		
1A	2	2	I	RS422 differential input (non-inverting) to receiver 1
2A	6	6	I	RS422 differential input (non-inverting) to receiver 2
1B	1	1	I	RS422 differential input (inverting) to receiver 1
2B	7	7	I	RS422 differential input (inverting) to receiver 2
1D	15	15	I	Logic data input to RS422 driver 1
2D	9	9	I	Logic data input to RS422 driver 2
DE	12	12	I	Driver enable (active high)
GND	8	8	—	Device ground pin
1R	3	3	O	Logic data output of RS422 receiver 1
2R	5	5	O	Logic data output of RS422 receiver 2
RE	4	4	I	Receiver enable pin (active low)
V <sub>CC</sub>	16	16	—	Power supply
1Y	14	14	O	RS-422 differential (non-inverting) driver output 1
2Y	10	10	O	RS-422 differential (non-inverting) driver output 2
1Z	13	13	O	RS-422 differential (inverting) driver output 1
2Z	11	11	O	RS-422 differential (inverting) driver output 2



**Figure 4-2. SN75ALS1178: N or NS Package  
(Top View)**

PINT			TYPE	DESCRIPTION
NAME	SO	TSSOP		
1A	2	2	I	RS422 differential input (non-inverting) to receiver 1
2A	6	6	I	RS422 differential input (non-inverting) to receiver 2
1B	1	1	I	RS422 differential input (inverting) to receiver 1
2B	7	7	I	RS422 differential input (inverting) to receiver 2
1D	15	15	I	Logic data input to RS422 driver 1
2D	9	9	I	Logic data input to RS422 driver 2
1DE	4	4	I	Driver 1 enable (active high)
2DE	12	12	I	Driver 2 enable (active high)
GND	8	8	—	Device ground
1R	3	3	O	Logic data output of RS422 receiver 1
2R	5	5	O	Logic data output of RS422 receiver 2
V <sub>CC</sub>	16	16	—	Power supply
1Y	14	14	O	RS-422 differential (non-inverting) driver output 1
2Y	10	10	O	RS-422 differential (non-inverting) driver output 2
1Z	13	13	O	RS-422 differential (non-inverting) driver output 1
2Z	11	11	O	RS-422 differential (non-inverting) driver output 2

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage, (see <sup>(2)</sup> )		7	V
V <sub>I</sub>	Input voltage, (DE, RE, and D inputs)		7	V
V <sub>O</sub>	Output voltage range, drivers	–9	14	V
	Input voltage range, receiver	–14	14	V
	Receiver differential-input voltage range, (see <sup>(3)</sup> )	–14	14	V
	Receiver low-level output current		50	mA
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260	°C
T <sub>stg</sub>	Storage temperature range	–65	150	°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential input voltage, are with respect to the network ground terminal.
- (3) Differential input voltage is measured at the noninverting terminal with respect to the inverting terminal.

### 5.2 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.75	5	5.25	V
V <sub>ID</sub>	Differential input voltage			±12	V
V <sub>OC</sub>	Common-mode output voltage	–7 <sup>(1)</sup>		12	V
V <sub>IC</sub>	Common-mode input voltage			±12	V
V <sub>IH</sub>	High-level input voltage	2			V
V <sub>IL</sub>	Low-level input voltage			0.8	V
I <sub>OH</sub>	High-level output current			–60	mA
				–400	µA
I <sub>OL</sub>	Low - level out output current			60	mA
				8	mA
T <sub>A</sub>	Operating free-air temperature	0		70	°C

- (1) The algebraic convention, where the less positive (more negative) limit is designated as minimum, is used in this data sheet for common-mode output and threshold voltage level only.

### 5.3 Thermal Information

THERMAL METRIC <sup>(1)</sup>		PDIP (N)	SO (NS)	UNIT
		16 Pins	16 Pins	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance (see <sup>(2)</sup> )	60.6	88.5	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	48.1	46.2	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	40.6	50.7	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	27.5	13.5	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	40.3	50.3	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC package thermal metrics](#) application report.
- (2) The package thermal impedance is calculated in accordance with JESD 51-7.

## 5.4 Driver Section

### 5.4.1 Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input clamp voltage	I <sub>I</sub> = -18 mA					-1.5	V
V <sub>OH</sub>	High-level output voltage	V <sub>IH</sub> = 2V,	V <sub>IL</sub> = 0.8V,	I <sub>OH</sub> = - 33mA		3.3		V
V <sub>OL</sub>	Low-level output voltage	V <sub>IH</sub> = 2V,	V <sub>IL</sub> = 0.8V,	I <sub>OL</sub> = 33mA		1.1		V
V <sub>OD1</sub>	Differential output voltage	I <sub>O</sub> = 0			1.5		6	V
V <sub>OD2</sub>	Differential output voltage	V <sub>CC</sub> = 5V,	R <sub>L</sub> = 100Ω,	See Figure 6-1	1/2V <sub>OD1</sub> or 2 <sup>(2)</sup>			V
		R <sub>L</sub> = 54Ω,	See Figure 6-1		1.5	2.5	5	
V <sub>OD3</sub>	Differential output voltage	See Note 4			1.5		5	V
Δ V <sub>OD</sub>	Change in magnitude of differential output voltage (see Note 5)	R <sub>L</sub> = 54Ω or 100Ω,		See Figure 6-1			±0.2	V
V <sub>OC</sub>	Common-mode output voltage	R <sub>L</sub> = 54Ω or 100Ω,		See Figure 6-1	-1 <sup>(3)</sup>		3	V
Δ V <sub>OC</sub>	Change in magnitude of common-mode output voltage (see Note 5)	R <sub>L</sub> = 54Ω or 100Ω,		See Figure 6-1			±0.2	V
I <sub>O(OFF)</sub>	Output current with power off	V <sub>CC</sub> = 0,	V <sub>O</sub> = -7V to 12V				±100	μA
I <sub>OZ</sub>	High-impedance-state output current	V <sub>O</sub> = -7V to 12V					±100	μA
I <sub>IH</sub>	High-level input current	V <sub>IH</sub> = 2.7V					100	μA
I <sub>IL</sub>	Low-level input current	V <sub>IL</sub> = 0.4V					-100	μA
I <sub>OS</sub>	Short-circuit output current	V <sub>O</sub> = -7V					-250	mA
		V <sub>O</sub> = V <sub>CC</sub>					250	
		V <sub>O</sub> = 12V					250	
		V <sub>O</sub> = 0V					150	
I <sub>CC</sub>	Supply current (total package)	No load	Outputs enabled			35	50	mA
			Outputs disabled			20	50	

(1) All typical values are at  $V_{CC} = 5\text{V}$  and  $T_A = 25^\circ\text{C}$ .

(2) The minimum  $V_{OD2}$  with a  $100\Omega$  load is either  $1/2 V_{OD1}$  or  $2\text{V}$ , whichever is greater.

(3) The algebraic convention, where the less positive (more negative) limit is designated as minimum, is used in this data sheet for common-mode output and threshold voltage levels only.

(4) See TIA/EIA-485-A Figure 6-3.5, test termination measurement 2.

(5)  $\Delta|V_{OD}|$  and  $\Delta|V_{OC}|$  are the changes in magnitude of  $V_{OD}$  and  $V_{OC}$ , respectively, that occur when the input is changed from a high level to a low level.

### 5.4.2 Switching Characteristics

at  $V_{CC} = 5\text{V}$ ,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$t_{PLH}$	Propagation delay time, high- to low-level output	$R_L = 60\Omega$ , $C_{L1} = C_{L2} = 100\text{pF}$ , See Figure 6-3		9	15	22	ns
$t_{PHL}$	Propagation delay time, low- to high-level output	$R_L = 60\Omega$ , $C_{L1} = C_{L2} = 100\text{pF}$ , See Figure 6-3		9	15	22	ns
$t_{sk}$	Output-to-output skew	$R_L = 60\Omega$ , $C_{L1} = C_{L2} = 100\text{pF}$ , See Figure 6-3		0	2	8	ns
$t_{PZH}$	Output enable time to high level	$C_L = 100\text{pF}$ ,	See Figure 6-4	30	35	50	ns
$t_{PZL}$	Output enable time to low level	$C_L = 100\text{pF}$ ,	See Figure 6-5	5	15	25	ns
$t_{PHZ}$	Output disable time from high level	$C_L = 15\text{pF}$ ,	See Figure 6-4	7	15	30	ns
$t_{PLZ}$	Output disable time from low level	$C_L = 15\text{pF}$ ,	See Figure 6-5	7	15	30	ns

## 5.5 Receiver Section

### 5.5.1 Electrical Characteristics

over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

PARAMETER			TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IT+</sub>	Positive-going input threshold voltage		V <sub>O</sub> = 2.7V,	I <sub>O</sub> = -0.4mA			0.2	V
V <sub>IT-</sub>	Negative-going input threshold voltage		V <sub>O</sub> = 0.5V,	I <sub>O</sub> = 8mA	-0.2 <sup>(2)</sup>			V
V <sub>hys</sub>	Input hysteresis voltage (V <sub>IT+</sub> - V <sub>IT-</sub> )					50		mV
V <sub>IK</sub>	Enable input clamp voltage	SN75ALS1177	I <sub>I</sub> = -18mA				-1.5	V
V <sub>OH</sub>	High-level output voltage		V <sub>ID</sub> = 200mV, I <sub>OH</sub> = -400μA, See Figure 6-2		2.7			V
V <sub>OL</sub>	Low-level output voltage		V <sub>ID</sub> = 200mV, I <sub>OL</sub> = 8mA, See Figure 6-2				0.45	V
I <sub>OZ</sub>	High-impedance-state output current	SN75ALS1177	V <sub>O</sub> = 0.4V to 2.4V				±20	μA
I <sub>I</sub>	Line input current (see Note 6)		Other input at 0V	V <sub>I</sub> = 12V V <sub>I</sub> = -7V			1 -0.8	mA
I <sub>IH</sub>	High-level input current, $\overline{RE}$	SN75ALS1177	V <sub>IH</sub> = 2.7V				20	μA
I <sub>IL</sub>	Low-level input current, $\overline{RE}$	SN75ALS1177	V <sub>IL</sub> = 0.4V				-100	μA
r <sub>i</sub>	Input resistance				12			kΩ
I <sub>OS</sub>	Short-circuit output current		V <sub>O</sub> = 0V,	See Note 7	-15		-85	mA
I <sub>CC</sub>	Supply current (total package)		No load,	outputs enabled		35	50	mA

- (1) All typical values are at V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.  
(2) The algebraic convention, where the less positive (more negative) limit is designated as minimum, is used in this data sheet for common-mode output and threshold voltage levels only.  
(3) Refer to TIA/EIA-422-B, TIA/EIA-423-A, and TIA/EIA-485-A for exact conditions.  
(4) Not more than one output should be shorted at a time.

### 5.5.2 Switching Characteristics

at V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C (unless otherwise noted)

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time, low- to high-level output		C <sub>L</sub> = 15pF,	See Figure 6-6	15	25	37	ns
t <sub>PHL</sub>	Propagation delay time, high- to low-level output		C <sub>L</sub> = 15pF,	See Figure 6-6	15	25	37	ns
t <sub>PZH</sub>	Output enable time to high level	SN75ALS1177	C <sub>L</sub> = 100pF,	See Figure 6-7	10	20	30	ns
t <sub>PZL</sub>	Output enable time to low level	SN75ALS1177	C <sub>L</sub> = 100pF,	See Figure 6-7	10	20	30	ns
t <sub>PHZ</sub>	Output disable time from high level	SN75ALS1177	C <sub>L</sub> = 15pF,	See Figure 6-7	3.5	12	16	ns
t <sub>PLZ</sub>	Output disable time from low level	SN75ALS1177	C <sub>L</sub> = 15pF,	See Figure 6-7	5	12	16	ns

## 6 Parameter Measurement Information

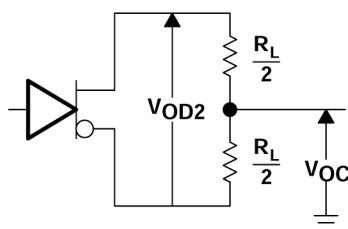


Figure 6-1. Driver Test Circuit,  $V_{OD}$  and  $V_{OC}$

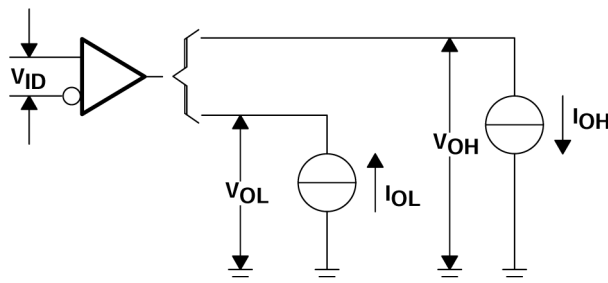
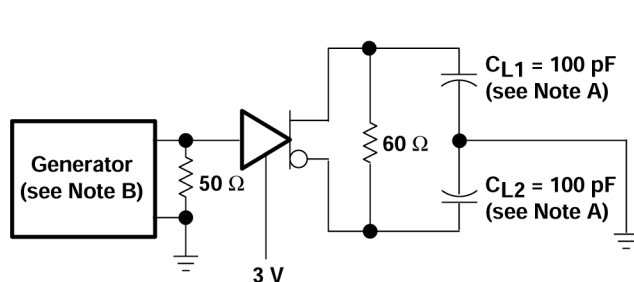
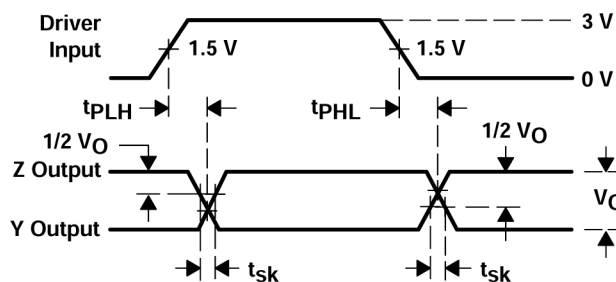


Figure 6-2. Receiver Test Circuit,  $V_{OH}$  and  $V_{OL}$



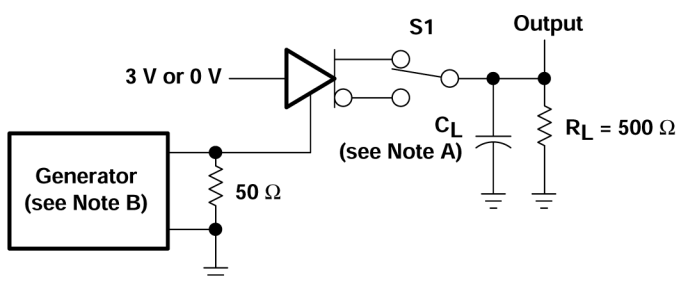
DRIVER TEST CIRCUIT



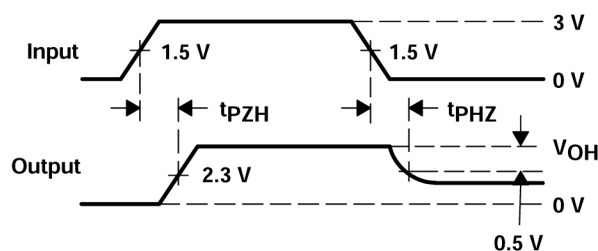
DRIVER VOLTAGE WAVEFORMS

- A.  $C_L$  includes probe and jig capacitance.  
B. The pulse generator has the following characteristics:  $PRR \leq 1\text{MHz}$ , 50% duty cycle,  $t_r \leq 10\text{ns}$ ,  $t_f \leq 10\text{ns}$ .

Figure 6-3. Driver Propagation Delay Times



DRIVER TEST CIRCUIT

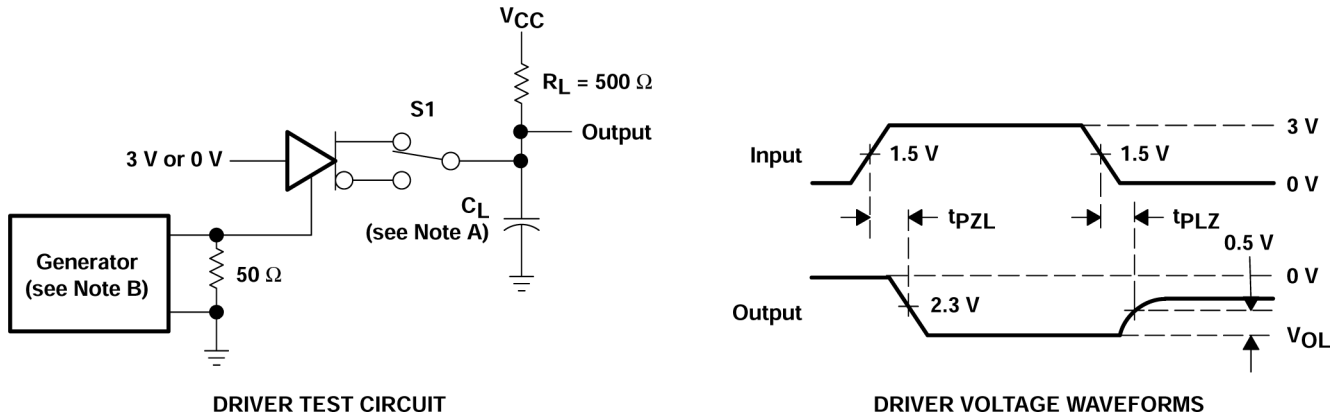


DRIVER VOLTAGE WAVEFORMS

- A.  $C_L$  includes probe and jig capacitance.  
B. The pulse generator has the following characteristics:  $PRR \leq 1\text{MHz}$ , 50% duty cycle,  $t_r \leq 10\text{ns}$ ,  $t_f \leq 10\text{ns}$ .

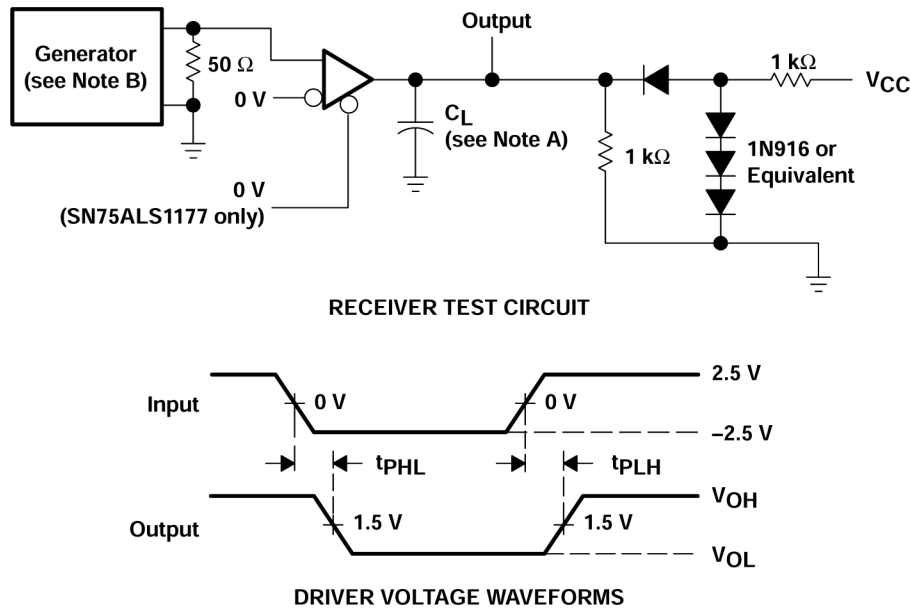
Figure 6-4. Driver Enable and Disable Times





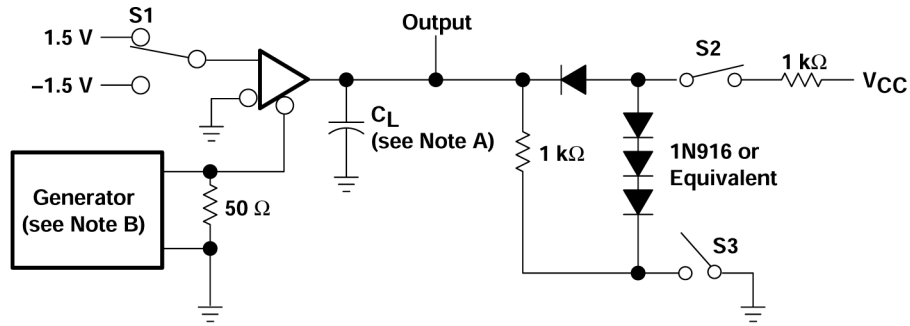
- A.  $C_L$  includes probe and jig capacitance.  
B. The pulse generator has the following characteristics:  $PRR \leq 1\text{MHz}$ , 50% duty cycle,  $t_r \leq 10\text{ns}$ ,  $t_f \leq 10\text{ns}$ .

**Figure 6-5. Driver Enable and Disable Times**

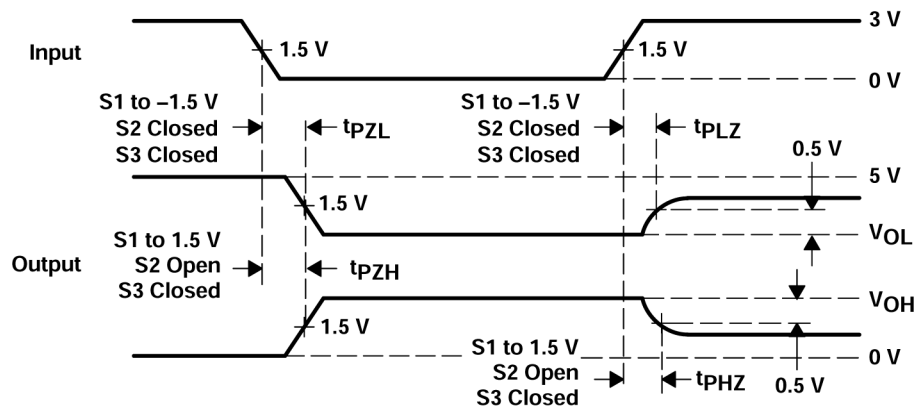


- A.  $C_L$  includes probe and jig capacitance.  
B. The pulse generator has the following characteristics:  $PRR \leq 1\text{MHz}$ , 50% duty cycle,  $t_r \leq 10\text{ns}$ ,  $t_f \leq 10\text{ns}$ .

**Figure 6-6. Receiver Propagation Delay Times**



RECEIVER TEST CIRCUIT



RECEIVER VOLTAGE WAVEFORMS

- A.  $C_L$  includes probe and jig capacitance.
- B. The pulse generator has the following characteristics:  $PRR \leq 1\text{MHz}$ , 50% duty cycle,  $t_r \leq 10\text{ns}$ ,  $t_f \leq 10\text{ns}$ .

**Figure 6-7. Receiver Output Enable and Disable Times**

## 7 Detailed Description

### 7.1 Device Functional Modes

**Table 7-1. SN75ALS1177, SN75ALS1178 Functional Table (Each Driver)**

INPUT D	ENABLE DE	OUTPUTS <sup>(1)</sup>	
		Y	Z
H	H	H	L
L	H	L	H
X	L	Z	Z

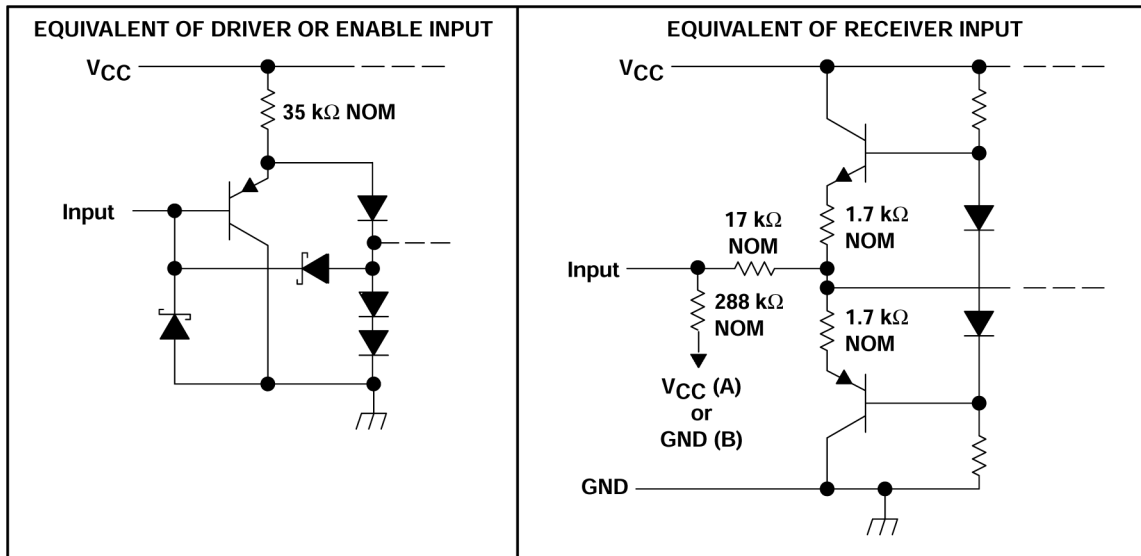
**Table 7-2. SN75ALS1177 Functional Table (Each Receiver)**

DIFFERENTIAL A–B	ENABLE RE <sup>(1)</sup>	OUTPUT Y <sup>(1)</sup>
$V_{ID} \geq 0.2V$	L	H
$-0.2V < V_{ID} < 0.2V$	L	?
$V_{ID} \leq -0.2V$	L	L
X	H	Z
Open	L	H

**Table 7-3. SN75ALS1178 Functional Table (Each Receiver)**

DIFFERENTIAL A–B	OUTPUT Y <sup>(1)</sup>
$V_{ID} \geq 0.2V$	H
$-0.2V < V_{ID} < 0.2V$	?
$V_{ID} \leq -0.2V$	L
Open	H

(1) H = High level, L = Low level, ? = Indeterminate, X = Irrelevant, Z = High impedance (off)



**Figure 7-1. Equivalent Schematics**

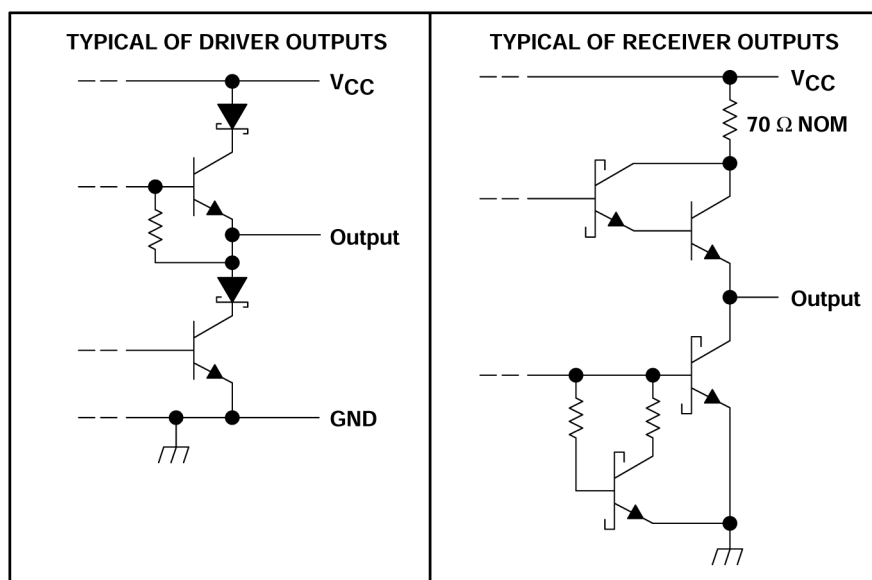


Figure 7-2. Schematics of Outputs

## 8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 8.1 Documentation Support

### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 8.3 Support Resources

[E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 8.4 Trademarks

E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 8.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

Changes from Revision B (February 2001) to Revision C (February 2024)	Page
• Changed the numbering format for tables, figures, and cross-references throughout the document.....	1

## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">SN75ALS1177N</a>	Active	Production	PDIP (N)   16	25   TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN75ALS1177N
SN75ALS1177N.A	Active	Production	PDIP (N)   16	25   TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN75ALS1177N
<a href="#">SN75ALS1177NSR</a>	Active	Production	SOP (NS)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS1177
SN75ALS1177NSR.A	Active	Production	SOP (NS)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS1177
<a href="#">SN75ALS1178N</a>	Active	Production	PDIP (N)   16	25   TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN75ALS1178N
SN75ALS1178N.A	Active	Production	PDIP (N)   16	25   TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	SN75ALS1178N
<a href="#">SN75ALS1178NSR</a>	Active	Production	SOP (NS)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS1178
SN75ALS1178NSR.A	Active	Production	SOP (NS)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS1178

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN75ALS1177NSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
SN75ALS1177NSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
SN75ALS1178NSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
SN75ALS1178NSR	SOP	NS	16	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1



## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN75ALS1177NSR	SOP	NS	16	2000	353.0	353.0	32.0
SN75ALS1177NSR	SOP	NS	16	2000	353.0	353.0	32.0
SN75ALS1178NSR	SOP	NS	16	2000	353.0	353.0	32.0
SN75ALS1178NSR	SOP	NS	16	2000	353.0	353.0	32.0

## TUBE



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
SN75ALS1177N	N	PDIP	16	25	506	13.97	11230	4.32
SN75ALS1177N.A	N	PDIP	16	25	506	13.97	11230	4.32
SN75ALS1178N	N	PDIP	16	25	506	13.97	11230	4.32
SN75ALS1178N.A	N	PDIP	16	25	506	13.97	11230	4.32

N (R-PDIP-T\*\*)

16 PINS SHOWN

## PLASTIC DUAL-IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

NOTES:

- A. All linear dimensions are in inches (millimeters).  
B. This drawing is subject to change without notice.
-  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).  
 The 20 pin end lead shoulder width is a vendor option, either half or full width.



# PACKAGE OUTLINE

NS0016A

SOP - 2.00 mm max height

SOP



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## NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



# EXAMPLE STENCIL DESIGN

NS0016A

SOP - 2.00 mm max height

SOP



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:7X

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NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

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